## Monitoring Production Line Performance to Reduce Failures

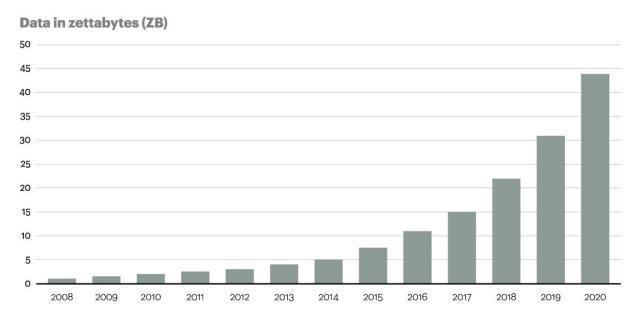
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#### Why data science in process monitoring?

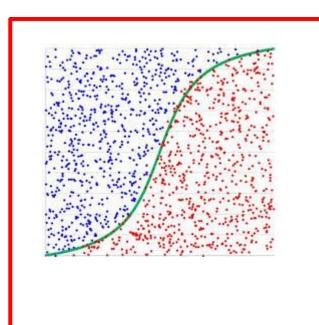
Figure 1

Data is growing at a 40 percent compound annual rate, reaching nearly 45 ZB by 2020



Source: Oracle, 2012

#### The task of fault analysis



**Binary Classification** 

ANOMALY VALUE TIME

**Anomaly Detection** 

### **Dataset Description**

We use the Bosch Production Line Performance data set .

Size of dataset: 14.3 Gb

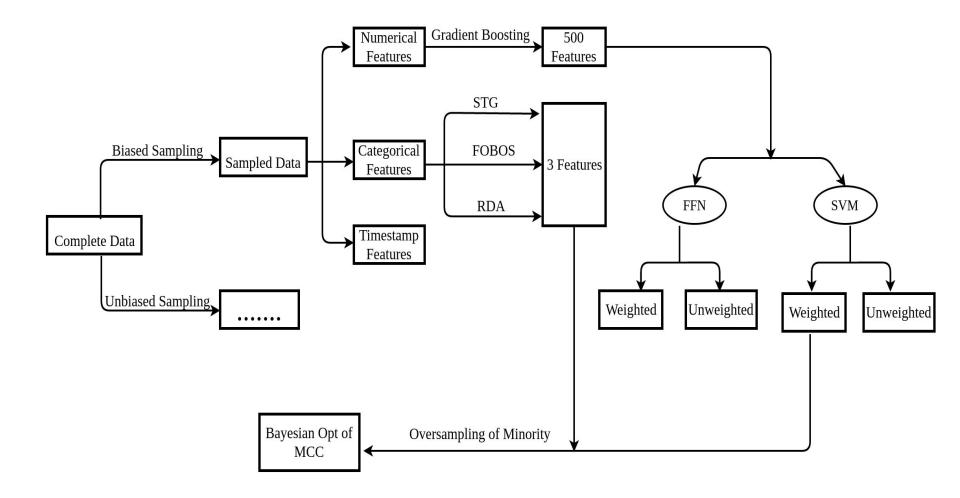
Features: Numerical (968), Categorical (2140) and Date stamps (1156)

Labels: indicating the sample as good or bad.

**#samples:** 11,84,687

# Four stage approach:

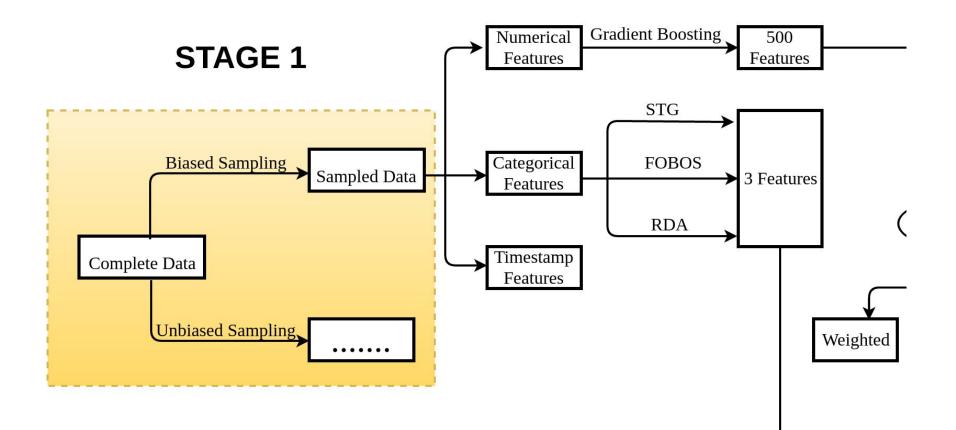
- 1. Undersampling
- 2. Feature selection
- 3. Choice of Base classifier
- 4. SMOTE + BayesOpt



### STAGE 1 Initial sampling

1) **Unbiased**: Select a subset of the original samples without taking into account the corresponding labels.

2) **Biased**: All the positive instances are retained while performing sampling

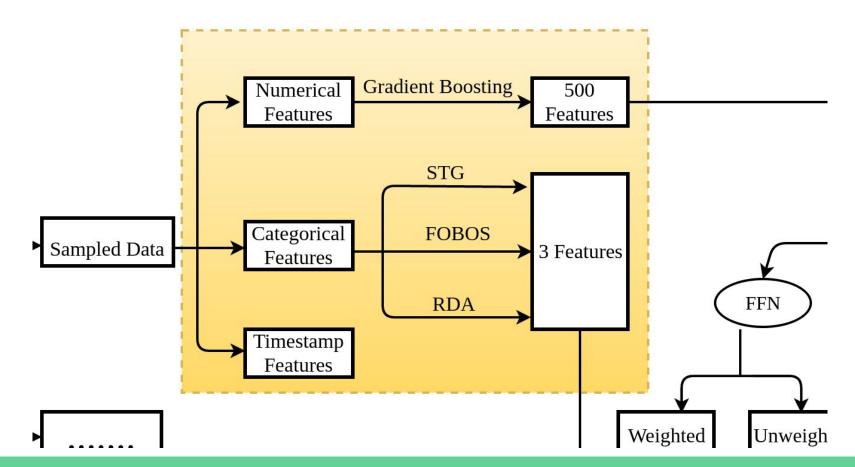


### STAGE 2 Feature selection

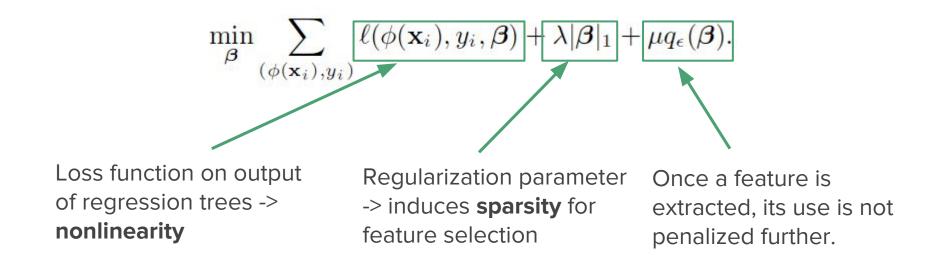
Different methods used for each of:

- Numeric
- Categorical
- Timestamp features

#### STAGE 2



#### **Gradient Boosting for Numerical Features**



Xu, Zhixiang, et al. "Gradient boosted feature selection." Proceedings of the 20th ACM SIGKDD international conference on Knowledge discovery and data mining. ACM, 2014.

# Sparse Online Learning for Categorical Features

3 features generated using 3 different methods:

- 1. Stochastic Truncated Gradient (STG)
- 2. Forward Backward Splitting (FOBOS)
- 3. Enhanced Regularized Dual Averaging (ERDA)

Each is trained on the train set and used to predict scores for train + test data. This score is used as feature.

#### **Stochastic Truncated Gradient**

$$f(w_i) = T_1(w_i - \eta \nabla_1 L(w_i, z_i), \eta g_i, \theta),$$

$$T_1(v_j, \alpha, \theta) = \begin{cases} \max(0, v_j - \alpha) & \text{if } v_j \in [0, \theta] & \text{direct} \\ \min(0, v_j + \alpha) & \text{if } v_j \in [-\theta, 0] \\ v_j & \text{otherwise} \end{cases}$$

To control shrinkage since direct rounding to zero is too aggressive.

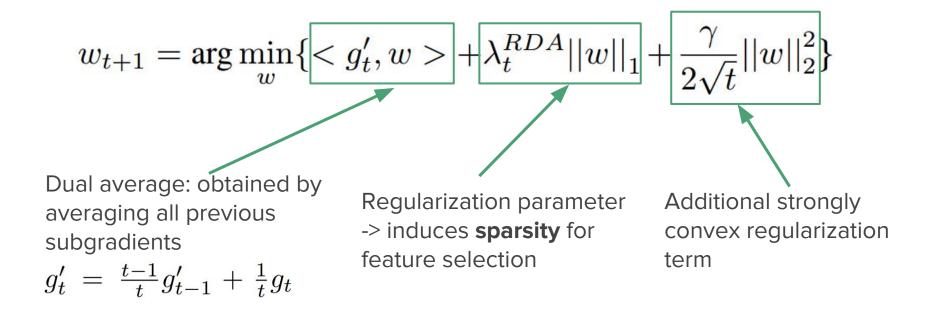
Langford, John, Lihong Li, and Tong Zhang. "Sparse online learning via truncated gradient." Journal of Machine Learning Research 10.Mar (2009): 777-801.

#### **Forward Backward Splitting**

Duchi, John, and Yoram Singer. "Efficient online and batch learning using forward backward splitting." Journal of Machine Learning Research 10.Dec (2009): 2899-2934.

selection

#### **Enhanced Regularized Dual Averaging**



Xiao, Lin. "Dual averaging methods for regularized stochastic learning and online optimization." Journal of Machine Learning Research 11.Oct (2010): 2543-2596.

#### Manual feature engineering for Timestamp features

Following features were extracted:

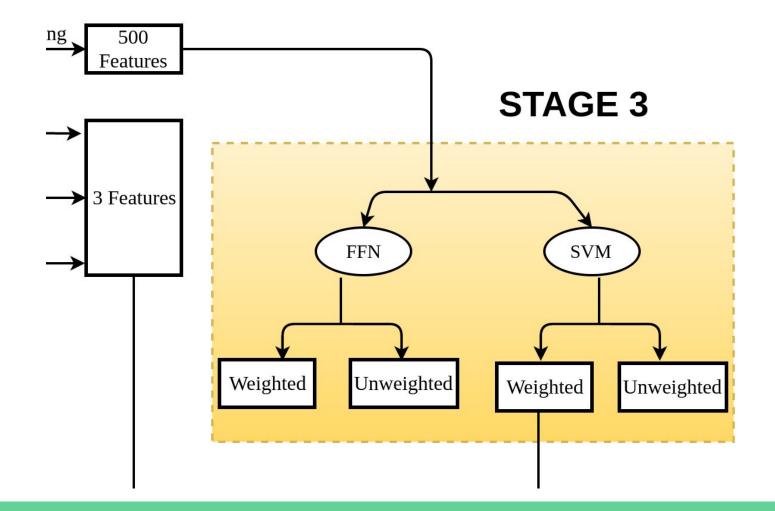
- 1. Minimum of all timestamps
- 2. Maximum of all timestamps
- 3. Mean of all timestamps
- 4. Duration of sample in production line
- 5. Number of NA features

**No significant improvement** in performance!

We ignore timestamp features.

### STAGE 3 Base Classifier

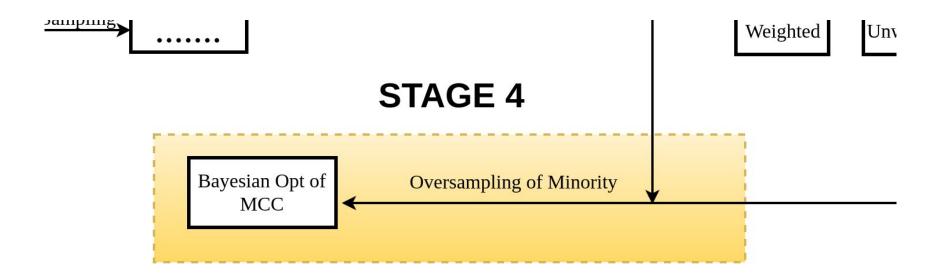
- Numerical features are used to select a base classifier.
- We experiment with feedforward neural networks (FFN) and support vector machines (SVM).
- Weighted and unweighted versions are evaluated.
- Finally the best performing model is chosen for further optimization.



### STAGE 4 SMOTE + BayesOpt

Two things are done:

- 1. Synthetic Minority Oversampling Technique (SMOTE)
- 2. Bayesian Optimization of the evaluation metric



### Synthetic Minority Oversampling Technique (SMOTE)

- Take the difference between the feature vector (sample) under consideration and its nearest neighbor.
- Multiply this difference by a random number between 0 and 1, and add it to the feature vector under consideration.
- This causes the selection of a random point along the line segment between two specific features.

Chawla, Nitesh V., et al. "SMOTE: synthetic minority over-sampling technique." Journal of artificial intelligence research 16 (2002): 321-357.

#### **Bayesian Optimization of MCC**

$$\begin{array}{lll} M(w) = & \mathrm{argmin} \ g(w) \\ & = & \mathrm{argmin} \ w \ FP + (1-w) \cdot FN \} \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & \\ & & & & & & & \\ & & & & & & \\ & & & & & & & \\ & & & & & & \\ & & & & &$$

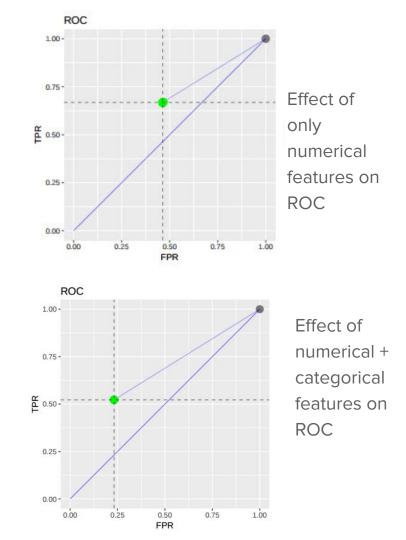
### Results

#### Three observations are made:

- 1. Effect of feature types
- 2. Base classifier performances
- 3. Effect of class weights

#### Effect of feature types

Most of the sensitivity of the base classifier was obtained due to the numerical features, and the 3 categorical features only contributed a little in improving performance.



#### Base classifier performances

Weighted SVM was found to perform best.

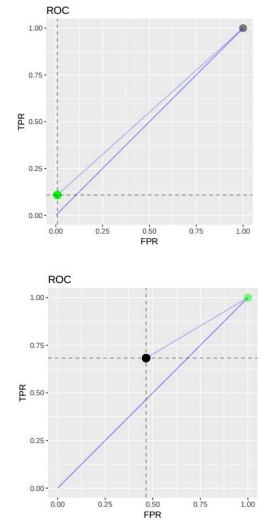
Model	No	Non-weighted			Weighted		
	Precision	Recall	F1-score	Precision	Recall	F1-score	
FFN	92.53	4.35	8.32	58.11	10.82	18.24	
SVM	84.61	0.77	1.53	13.25	67.39	22.15	

#### Base classifier performances

The AUCs for the models are:

FFN = 0.5499

SVM = 0.6014



ROC variation for feedforward network (FFN)

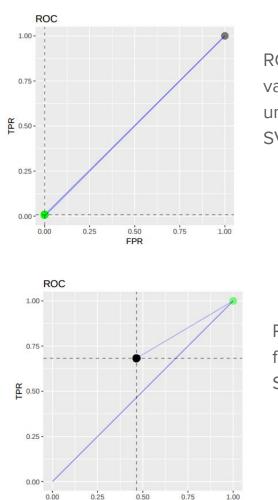
ROC variation for support vector machine (SVM) classifiers.

#### Effect of class weights

The AUCs for the models are:

Unweighted SVM = 0.5038

Weighted SVM = 0.6014



FPR

ROC variation for unweighted SVM

ROC variation for weighted SVM **Bayesian Optimization** on evaluation metric can improve performance by as much as **3-4%**.

### Conclusion

Simple task of binary classification can be complex in an industrial setting.

Several preprocessing, feature selection, and classifier optimization methods were explored.

**Future work:** Better base classifiers, extracting more features from categorical and timestamp features.